



## Product Change Notification / GBNG-19TOBI439

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**Date:**

15-Mar-2022

**Product Category:**

Analog Temperature Sensors, Depletion Mode MOSFETs, Linear Regulator ICs, Linear Regulators, Voltage References

**PCN Type:**

Manufacturing Change

**Notification Subject:**

CCB 4885 Final Notice: Qualification of CEL-8240 GS as a new mold compound material for selected Supertex CL2xx, CL52xx, LND150, MCP15xx, MCP170x and MCP970xx device families available in 3L TO-92 package assembled at CRTK assembly site.

**Affected CPNs:**

[GBNG-19TOBI439\\_Affected\\_CPN\\_03152022.pdf](#)

[GBNG-19TOBI439\\_Affected\\_CPN\\_03152022.csv](#)

**Notification Text:**

**PCN Status:**Final Notification

**PCN Type:**Manufacturing Change

**Microchip Parts Affected:**Please open one of the files found in the Affected CPNs section.

Note: For your convenience Microchip includes identical files in two formats (.pdf and .xls)

**Description of Change:**Qualification of CEL-8240 GS as a new mold compound material for selected Supertex CL2xx, CL52xx, LND150, MCP15xx, MCP170x and MCP970xx device families available in 3L TO-92 package assembled at CRTK assembly site.

**Pre and Post Change Summary:**

		Pre Change		Post Change
Assembly Site		Greatek Electronic Inc. (GTK)	Cirtek Electronics Corporation  (CRTK)	Cirtek Electronics Corporation  (CRTK)
Wire Material		Au	Au	Au
Die Attach Material		CRM1076DJ-G	84-1LMISR4	84-1LMISR4
Molding Compound Material		G600F	EME-G600	CEL-8240 GS
Lead frame	Material	CDA194	A194	A194
	Lead lock	No	No	No
	Design	See attached Pre and Post change comparison		
Package Lay-out		See attached Pre and Post change comparison		

Note: \* C194, A194 or CDA194 Lead frame material are the same, it is just a MCHP internal labelling difference.

**Impacts to Data Sheet:**None

**Change Impact:**None

**Reason for Change:**To improve productivity and on-time delivery performance by qualifying CEL-8240 GS as a new mold compound material at CRTK assembly site.

**Change Implementation Status:**In Progress

**Estimated First Ship Date:**April 20, 2022 (date code: 2217)

Note: Please be advised that after the estimated first ship date customers may receive pre and post change parts.

**Time Table Summary:**

	November 2021					>	March 2022					April 2022			
	4 5	4 6	4 7	4 8	4 9		1 0	1 1	1 2	1 3	1 4	15	16	17	18
Initial PCN Issue Date	X														
Qual Report Availability								X							
Final PCN Issue								X							

Date																				
Estimated Implementation Date																			X	

**Method to Identify Change:**

Traceability code

**Qualification Report:** Please open the attachments included with this PCN labeled as PCN\_#\_Qual\_Report.

**Revision History:**

**November 04, 2021:** Issued initial notification.

**March 15, 2022:** Issued final notification. Attached the Qualification Report. Provided estimated first ship date to be on April 20, 2022. Updated the package lay-out in Pre and Post change comparison (ppt file) for CRTK – Die sit either flat side or curve side depending on die or BD lay-out on some devices.

The change described in this PCN does not alter Microchip’s current regulatory compliance regarding the material content of the applicable products.

**Attachments:**

- [PCN\\_GBNG-19TOBI439\\_Qual\\_Report.pdf](#)
- [PCN\\_GBNG-19TOBI439\\_Pre and Post Change\\_Summary.pdf](#)

Please contact your local [Microchip sales office](#) with questions or concerns regarding this notification.

**Terms and Conditions:**

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If you wish to change your PCN profile, including opt out, please go to the [PCN home page](#) select login and sign into your myMicrochip account. Select a profile option from the left navigation bar and make the applicable selections.

**CCB 4885**  
**Pre and Post Change Summary**  
**PCN #: GBNG-19TOBI439**



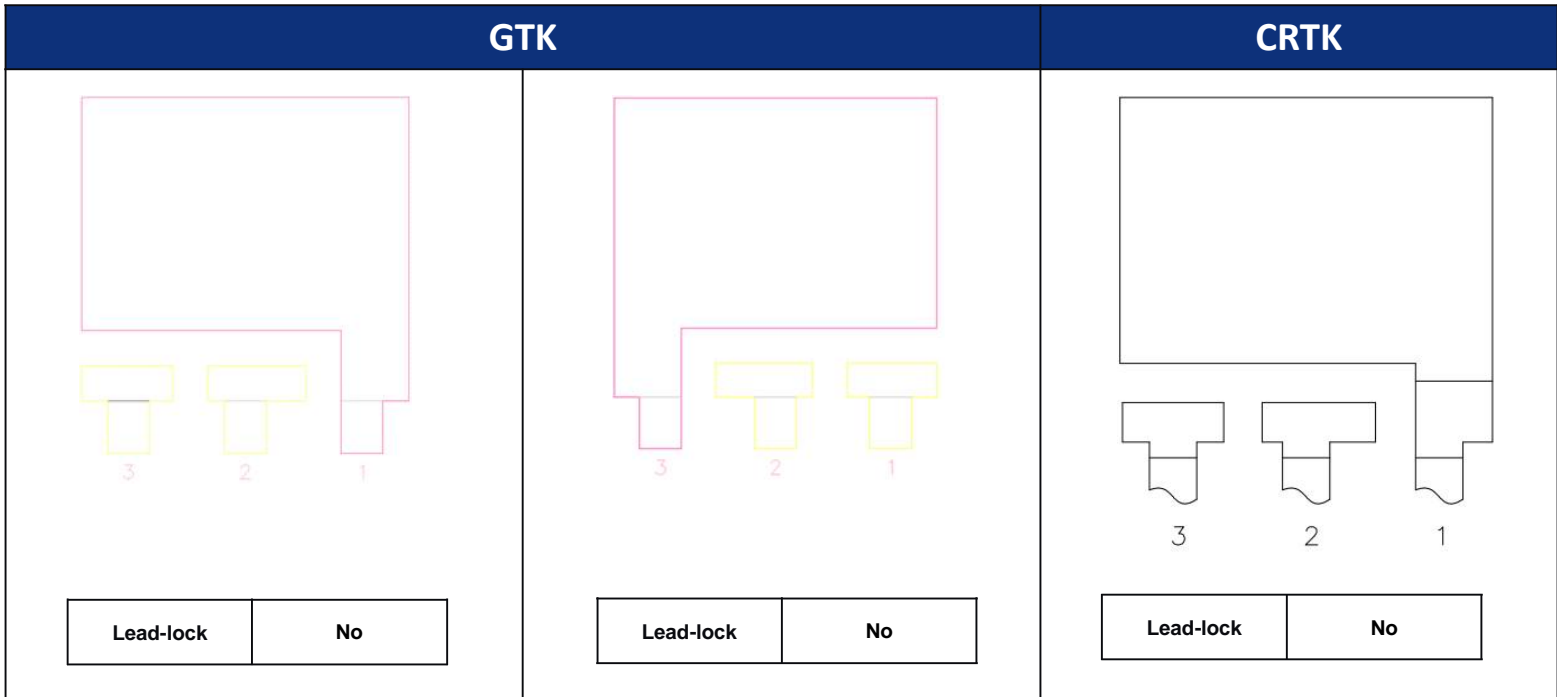
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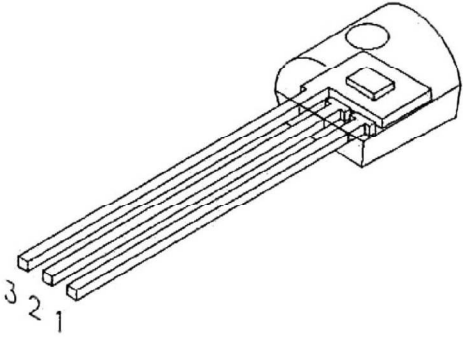
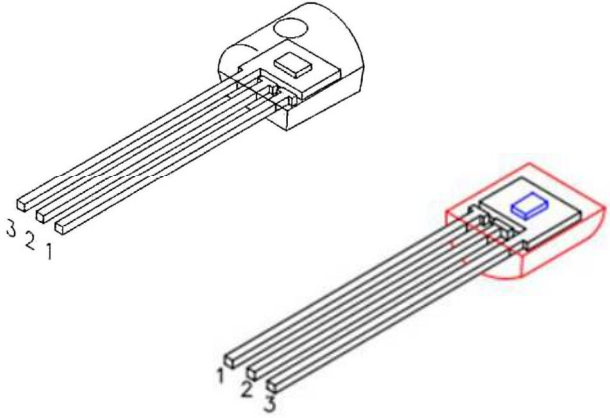
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# Lead Frame Comparison



Note: Mold compound material fills the leadlock hole, which provides improved protection against moisture penetration along the edge of the leads (pins) of the package.

# Package Lay-out

GTK	CRTK
 <p>The diagram shows a GTK package with three leads labeled 3, 2, and 1 from left to right. The package is shown in a perspective view, highlighting the die and the lead connections.</p>	 <p>The diagram shows a CRTK package with three leads labeled 3, 2, and 1 from left to right. A second view shows the package with a red outline around the die area, indicating the die placement. The leads are labeled 1, 2, and 3 from left to right in this view.</p> <p>Note: Die sit on flat side or curve side depending on die or BD lay-out on some devices</p>



**MICROCHIP**

**QUALIFICATION REPORT SUMMARY**  
RELIABILITY LABORATORY

**PCN #: GBNG-19TOBI439**

**Date:**  
**March 1, 2022**

**Qualification of CEL-8240 GS as a new mold compound material for selected Supertex CL2xx, CL52xx, LND150, MCP15xx, MCP170x and MCP970xx device families available in 3L TO-92 package assembled at CRTK assembly site.**



## MICROCHIP PACKAGE QUALIFICATION REPORT

<b>Purpose</b>	<b>Qualification of CEL-8240 GS as a new mold compound material for selected Supertex CL2xx, CL52xx, LND150, MCP15xx, MCP170x and MCP970xx device families available in 3L TO-92 package assembled at CRTK assembly site.</b>
<b>CN</b>	E000083651
<b>QUAL ID</b>	R2200001 Rev. A
<b>MP CODE</b>	ABBA14A2XA33
<b>Part No.</b>	MCP1700-3302E/TO
<b>CCB No.</b>	4885
<b><u>Package</u></b>	
<b>Type</b>	3L TO-92
<b><u>Lead Frame</u></b>	
<b>Paddle size</b>	140 x 100 mils
<b>Material</b>	A194
<b>Surface</b>	Ag
<b>Process</b>	Stamping
<b>Lead Lock</b>	No
<b>Part Number</b>	TO03NH2105
<b><u>Die attach material</u></b>	
<b>Epoxy</b>	84-1LMISR4
<b>Wire</b>	Au wire
<b>Mold Compound</b>	CEL-8240 GS
<b>Plating Composition</b>	Matte Sn





# MICROCHIP PACKAGE QUALIFICATION REPORT

## Manufacturing Information:

Assembly Lot No.	Wafer No.	Date Code
CRTK223500001.000	TMPE222159703.300	2147QV8
CRTK223500002.000	TMPE222159703.300	2147QVW
CRTK223500003.000	TMPE222159703.300	2147QWG

**Result**

Pass

Fail

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3L TO-92 assembled by CRTK pass reliability test per QCI-39000.

# PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS.	Result	Remarks
<b>Electrical Test</b>	<b>Electrical Test:</b> +25°C and 125°C System: TTS	JESD22- A113	693(0)	693		Good Devices
<b>Temp Cycle</b>	<b>Stress Condition:</b> -65°C to +150°C, 500 Cycles System: TABAI ESPEC TSA-70H Inspection: External crack inspection all units under 40X Optical magnification <b>Electrical Test:</b> +125°C System: TTS <b>Bond Strength:</b> Wire Pull (>4.00 grams) Bond Shear (>18.00 grams)	JESD22- A104	231(0)	231 0/231	Pass	77 units / lot
<b>UNBIASED-HAST</b>	<b>Stress Condition:</b> +130°C/85%RH, 96 hrs. System: HAST 6000X <b>Electrical Test:</b> +25°C System: TTS1000	JESD22- A118	231(0)	231 0/231	Pass	77 units / lot
<b>HAST</b>	<b>Stress Condition:</b> +130°C/85%RH, 96 hrs. <b>Bias Volt:</b> 6.0 Volts System: HAST 6000X <b>Electrical Test:</b> +25°C and 125°C System: TTS	JESD22- A110	231(0)	231 0/231	Pass	77 units / lot

## PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS.	Result	Remarks
<b>High Temperature Storage Life</b>	<b>Stress Condition:</b> Bake 175°C, 504 hrs System: SHEL LAB	JESD22- A103		45		45 units
	<b>Electrical Test:</b> +25°C and 125°C System: TTS		45(0)	0/45	Pass	
<b>Solderability Temp 245°C</b>	<b>Steam Aging:</b> Temp 93°C,8Hrs System: SAS-3000 <b>Solder Dipping:</b> Solder Temp.245°C Solder material: Pb Free Sn 95.5Ag3.9 Cu0.6 System: ERSA RA 2200D Visual Inspection: External Visual Inspection	JESD22B- 102E	22(0)	22  22 0/22	Pass	
<b>Lead Integrity</b>	15 Leads from a minimum of 5 units, 1 lot. System: Strain	JESD22 B105	15(0)	0/15	Pass	
<b>Wire sweep</b>	Wire sweep Inspection 15 Wires / lot	-	45(0)  Wires	0/45	Pass	
<b>Physical Dimensions</b>	Physical Dimension, 10 units per lot	JESD22- B100/B108	30(0) Units	0/30	Pass	
<b>Bond Strength Data Assembly</b>	Wire Pull (>4.00 grams)	Mil. Std.	30 (0) Wires	0/30	Pass	
	Bond Shear (>13.00 grams)	883-2011	30 (0) bonds	0/30	Pass	

GBNG-19TOBI439 - CCB CL52xx LND150 MCP15xx MCP170x and MCP970xx device families avail

Affected Catalog Part Numbers(CPN)

CL25N3-G  
CL2N3-G  
CL2N3-G-D591  
CL2N3-G-D602  
CL2N3-G-P002  
CL520N3-G  
CL525N3-G  
LND150N3-G  
LND150N3-G-P002  
LND150N3-G-P003  
LND150N3-G-P013  
LND150N3-G-P014  
MCP1525-I/TO  
MCP1541-I/TO  
MCP1700-1202E/TO  
MCP1700-1302E/TO  
MCP1700-1502E/TO  
MCP1700-1802E/TO  
MCP1700-2102E/TO  
MCP1700-2302E/TO  
MCP1700-2502E/TO  
MCP1700-2702E/TO  
MCP1700-2802E/TO  
MCP1700-3002E/TO  
MCP1700-3102E/TO  
MCP1700-3302E/TO  
MCP1700-4002E/TO  
MCP1700-5002E/TO  
MCP1700-3001E/TO  
MCP9700-E/TO  
MCP9700A-E/TO  
MCP9701-E/TO  
MCP9701A-E/TO  
MCP1702-1202E/TO  
MCP1702-1502E/TO  
MCP1702-1802E/TO  
MCP1702-2502E/TO  
MCP1702-2802E/TO  
MCP1702-3002E/TO  
MCP1702-3302E/TO  
MCP1702-3602E/TO  
MCP1702-4002E/TO

MCP1702-5002E/TO